TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

# TC74VCX74FT, TC74VCX74FK

Low-Voltage Dual D-Type Flip-Flop with 3.6-V Tolerant Inputs and Outputs

The TC74VCX74FT/FK is a high-performance CMOS D-type flip-flop which is guaranteed to operate from 1.2-V to 3.6-V. Designed for use in 1.5V, 1.8V, 2.5V or 3.3V systems, it achieves high-speed operation while maintaining the CMOS low power dissipation.

It is also designed with overvoltage tolerant inputs and outputs up to  $3.6\ V.$ 

The signal level applied to the D INPUT is transferred to Q  $\overline{\text{OUTPUT}}$  during the positive going transition of the CK pulse.  $\overline{\text{CLR}}$  and  $\overline{\text{PR}}$  are independent of the CK and are accomplished by setting the appropriate input low.

All inputs are equipped with protection circuits against static discharge.

### **Features**

- Low-voltage operation: VCC = 1.2 to 3.6 V
- High-speed operation:  $t_{pd} = 3.5 \text{ ns (max)} (V_{CC} = 3.0 \text{ to } 3.6 \text{ V})$

 $t_{pd} = 4.6 \text{ ns (max) (V}_{CC} = 2.3 \text{ to } 2.7 \text{ V}$ 

 $: t_{pd} = 9.2 \text{ ns (max) (V}_{CC} = 1.65 \text{ to } 1.95 \text{ V})$ 

 $t_{pd} = 18.4 \text{ ns (max)} (V_{CC} = 1.4 \text{ to } 1.6 \text{ V})$ 

 $t_{pd} = 46.0 \text{ns} \text{ (max) (VCC} = 1.2 \text{ V)}$ 

Output current: I<sub>OH</sub>/I<sub>OL</sub> = ±24 mA (min) (V<sub>CC</sub> = 3.0 V)

 $: I_{OH}/I_{OL} = \pm 18 \text{ mA (min) (V}_{CC} = 2.3 \text{ V)}$ 

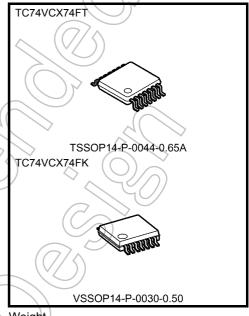
 $: I_{OH}/I_{OL} = \pm 6 \text{ mA (min)} (V_{CC} = 1.65 \text{ V})$ 

 $: I_{OH}/I_{OL} = \pm 2 \text{ mA (min) (V}_{CC} = 1.4 \text{ V)}$ 

- Latch-up performance: -300 mA
- ESD performance: Machine model  $\geq \pm 200 \text{ V}$

Human body model ≥ ±2000 V

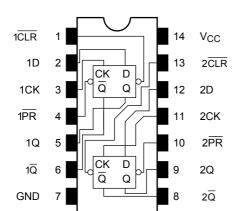
- Package: TSSOP and VSSOP (US)
- · Power-down protection provided on all inputs and outputs



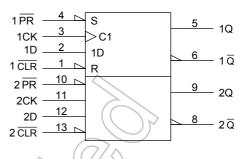
Weight

TSSOP14-P-0044-0.65A : 0.06 g (typ.) VSSOP14-P-0030-0.50 : 0.02 g (typ.)

### Pin Assignment (top view)



### **IEC Logic Symbol**



### **Truth Table**

Function	Outputs		Inputs				
T dilction	Q	Q	CK	D	PR	CLR	
Clear	Н	L	Х	Х	Н	L	
Preset	L	Н	Х	Х	L	Н	
- 4(	Н	Н	Х	Х	L	L	
-	Н	L		L	Н	Н	
	L	Н		Н	Н	Н	
No change	Qn	Qn	ightharpoons	Х	Н	Н	
				·	·		

X: Don't care

## **Absolute Maximum Ratings (Note 1)**

Characteristics	Cymbol	Rating	Unit
Characteristics	Symbol	Rating	Offic
Power supply voltage	Vcc	-0.5 to 4.6	٧
DC input voltage	VIN	-0,5 to 4.6	V
DC output voltage	V <sub>OUT</sub>	-0.5 to 4.6 (Note 2) -0.5 to V <sub>CC</sub> + 0.5 (Note 3)	>
Input diode current	I <sub>IK</sub>	-50	mA
Output diode current	lok	±50 (Note 4)	mA
DC output current	lout	±50	mA
Power dissipation	PD	180	mW
DC V <sub>CC</sub> /ground current	ICC/IGND	±100	mA
Storage temperature	T <sub>stg</sub>	-65~150	°C

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2:  $V_{CC} = 0 V$ 

Note 3: High or low state. IOUT absolute maximum rating must be observed.

Note 4:  $V_{OUT} < GND, V_{OUT} > V_{CC}$ 

### **Operating Ranges (Note 1)**

Characteristics	Symbol	Symbol Rating	
Power supply voltage	V <sub>CC</sub>	1.2 to 3.6	V
Input voltage	V <sub>IN</sub>	-0.3 to 3.6	V
Output voltage	V	0 to 3.6 (Note 2)	V
Output voltage	Vout	0 to V <sub>CC</sub> (Note 3)	V
		±24 (Note 4)	
Output current		±18 (Note 5)	
Output current	I <sub>OH</sub> /I <sub>OL</sub>	±6 (Note 6)	mA (
		±2 (Note 7)	
Operating temperature	T <sub>opr</sub>	-40 to 85	(°C)
Input rise and fall time	dt/dv	0 to 10 (Note 8)	ns/V

Note 1: The operating ranges must be maintained to ensure the normal operation of the device: Unused inputs must be tied to either V<sub>CC</sub> or GND.

Note 2:  $V_{CC} = 0 V$ 

Note 3: High or low state

Note 4:  $V_{CC} = 3.0 \text{ to } 3.6 \text{ V}$ 

Note 5:  $V_{CC} = 2.3 \text{ to } 2.7 \text{ V}$ 

Note 6:  $V_{CC} = 1.65 \text{ to } 1.95 \text{ V}$ Note 7:  $V_{CC} = 1.4 \text{ to } 1.6 \text{ V}$ 

Note 8:  $V_{IN} = 0.8$  to 2.0 V,  $V_{CC} = 3.0$  V

### **Electrical Characteristics**

## DC Characteristics (Ta = -40 to $85^{\circ}$ C, 2.7 V < V<sub>CC</sub> $\leq$ 3.6 V)

Characteris	Characteristics Symbol Test Condition		ndition	V <sub>CC</sub> (V)	Min	Max	Unit			
lanut valta aa	H-level	VIH	) , (07	· \	2.7 to 3.6	2.0	_	V		
Input voltage L-level		VIL		2)	2.7 to 3.6	_	0.8	V		
		$\supset$		$I_{OH} = -100 \mu A$	2.7 to 3.6	V <sub>CC</sub> - 0.2	_			
	H-level	V <sub>OH</sub>	VIN = VIH or VIL	I <sub>OH</sub> = -12 mA	2.7	2.2	_			
Z			$\wedge$	$I_{OH} = -18 \text{ mA}$	3.0	2.4	_			
Output voltage			4	I <sub>OH</sub> = -24 mA	3.0	2.2	_	٧		
			$I_{OL} = 100 \mu A$	2.7 to 3.6	_	0.2				
	L-level	Vol	> (( ))	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	$I_{OL} = 12 \text{ mA}$	2.7	_	0.4	
	L-level		AIN = VIH OI VIL	$I_{OL} = 18 \text{ mA}$	3.0	_	0.4			
				$I_{OL} = 24 \text{ mA}$	3.0	_	0.55			
Input leakage curren	nt	I <sub>IN</sub>	$V_{IN} = 0$ to 3.6 V		2.7 to 3.6	_	±5.0	μΑ		
Power off leakage cu	urrent	I <sub>OFF</sub>	$V_{IN}$ , $V_{OUT} = 0$ to 3.6 V		0	_	10.0	μΑ		
Quioscont supply ou	Quiescent supply current		V <sub>IN</sub> = V <sub>CC</sub> or GND		2.7 to 3.6	_	20.0			
Quiescent supply cu			V <sub>CC</sub> ≤ V <sub>IN</sub> ≤ 3.6 V		2.7 to 3.6	_	±20.0	μΑ		
Increase in I <sub>CC</sub> per i	nput	Δlcc	$V_{IH} = V_{CC} - 0.6 V$		2.7 to 3.6	_	750			



## DC Characteristics (Ta = -40 to 85°C, 2.3 V $\leq$ V<sub>CC</sub> $\leq$ 2.7 V)

Characteris	stics	Symbol	Test Condition Vcc (V		V <sub>CC</sub> (V)	Min	Max	Unit
Input voltage	H-level	V <sub>IH</sub>	_		2.3 to 2.7	1.6	_	V
input voitage	L-level	V <sub>IL</sub>	_		2.3 to 2.7	_	0.7	V
				I <sub>OH</sub> = -100 μA	2.3 to 2.7	V <sub>CC</sub> - 0.2		
Output voltage	H-level	V <sub>OH</sub>	$V_{IN} = V_{IH}$ or $V_{IL}$	I <sub>OH</sub> = -6 mA	2.3	2.0	_	
				I <sub>OH</sub> = -12 mA	2.3	1.8	_	
				I <sub>OH</sub> = -18 mA	2.3	1.7		V
				I <sub>OL</sub> = 100 μA	2.3 to 2.7		0.2	
	L-level	V <sub>OL</sub>	$V_{IN} = V_{IH}$ or $V_{IL}$	I <sub>OL</sub> = 12 mA	2.3		0.4	
				I <sub>OL</sub> = 18 mA	2.3		0.6	
Input leakage currer	nt	I <sub>IN</sub>	V <sub>IN</sub> = 0 to 3.6 V		2.3 to 2.7	12	±5.0	μΑ
Power-off leakage c	urrent	I <sub>OFF</sub>	$V_{IN}$ , $V_{OUT} = 0$ to 3.6 V	(7)	0		10.0	μΑ
Quiescent supply cu	Ovice and average average		$V_{IN} = V_{CC}$ or GND		2.3 to 2.7	14	20.0	μА
Quiescent supply Co	ni ciil	Icc	V <sub>CC</sub> ≤ V <sub>IN</sub> ≤ 3.6 V		2.3 to 2.7	70	±20.0	μΑ

## DC Characteristics (Ta = -40 to $85^{\circ}$ C, 1.65 V $\leq$ V<sub>CC</sub> < 2.3 V)

Characteris	stics	Symbol	Test Condition	V <sub>CC</sub> (V)	Min	Max	Unit
Input voltage	H-level	V <sub>IH</sub>		1.65 to 2.3	0.65 × V <sub>CC</sub>	_	V
mput voitage	L-level	VIL (		1.65 to 2.3	_	0.2 × V <sub>CC</sub>	V
	H-level	VoH	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	1.65 to 2.3	V <sub>CC</sub> - 0.2		
Output voltage		1	l <sub>OH</sub> = −6 mA	1.65	1.25	_	V
	L-level	V <sub>OL</sub>	$V_{IN} = V_{IH}$ or $V_{IL}$ $I_{OL} = 100 \mu A$	1.65 to 2.3	_	0.2	
	L-level	VOL	I <sub>OL</sub> = 6 mA	1.65	_	0.3	
Input leakage currer	nt	V <sub>IIN</sub>	V <sub>IN</sub> = 0 to 3.6 V	1.65 to 2.3	_	±5.0	μА
Power-off leakage c	urrent	l <sub>OFF</sub>	V <sub>IN</sub> , V <sub>OUT</sub> = 0 to 3.6 V	0	_	10.0	μА
		laa	V <sub>IN</sub> = V <sub>CC</sub> or GND	1.65 to 2.3	_	20.0	^
Quiescent supply cu	ment	Icc	V <sub>CC</sub> ≤ V <sub>IN</sub> ≤ 3.6 V	1.65 to 2.3	_	±20.0	μА

## DC Characteristics (Ta = -40 to $85^{\circ}$ C, 1.4 V $\leq$ V<sub>CC</sub> < 1.65 V)

Characteris	stics	Symbol	Test Condition $V_{CC}\left(V\right)$		V <sub>CC</sub> (V)	Min	Max	Unit	
Input voltage	H-level	V <sub>IH</sub>	_		1.4 to 1.65	0.65 × V <sub>CC</sub>		V	
	L-level	V <sub>IL</sub>	_		1.4 to 1.65		0.05 × V <sub>CC</sub>	V	
		H-level	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -100 μA	1.4 to 1.65	VCC 0.2		
Output voltage			I <sub>OH</sub> = -2 mA	71.4	1.05	_	V		
	L-level	\/a.	V <sub>OL</sub> V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 100 μA	1.4 to 1.65	_	0.05		
	L-level	VOL		I <sub>OL</sub> = 2 mA	1.4	_	0.35		
Input leakage curre	nt	I <sub>IN</sub>	V <sub>IN</sub> = 0 to 3.6 V		1.4 to 1.65		±5.0	μА	
Power-off leakage of	current	l <sub>OFF</sub>	$V_{IN}$ , $V_{OUT} = 0$ to 3.6 V		0	7	10.0	μА	
Ouissant summir summer		loo	$V_{IN} = V_{CC}$ or GND		1.4 to 1.65		20.0	^	
Quiescent supply cu	an ciil	Icc	$V_{CC} \le V_{IN} \le 3.6 \text{ V}$	(7/6)	1.4 to 1.65	J->	±20.0	μА	

## DC Characteristics (Ta = -40 to 85°C, 1.2 V $\leq$ V<sub>CC</sub> $\ll$ 1.4 V)

Characteris	stics	Symbol	Test Con	V <sub>CC</sub> (V)	Min	Max	Unit	
Innut voltage	H-level	V <sub>IH</sub>	4()-	1.2 to 1.4	0.8 × V <sub>CC</sub>		V	
Input voltage	L-level	V <sub>IL</sub>			1.2 to 1.4	l	0.05 × V <sub>CC</sub>	V
Output voltage	H-level	Vон (	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	Іон = −100 μА	1.2	V <sub>CC</sub> - 0.1		V
	L-level	VoL	$V_{IN} = V_{IH}$ or $V_{IL}$	$I_{OL} = 100 \mu A$	1.2	_	0.05	
Input leakage currer	nt	(I <sub>IN</sub> //	V <sub>IN</sub> = 0 to 3.6 V	3	1.2		±5.0	μΑ
Power-off leakage c	urrent	IOFF	V <sub>IN</sub> , V <sub>OUT</sub> = 0 to 3.6 V	$\wedge$	0	_	10.0	μΑ
Quiescent supply current		loo	V <sub>IN</sub> = V <sub>CC</sub> or GND		1.2		20.0	μА
Quiescent supply co	ment	lcc	$V_{CC} \le V_{IN} \le 3.6 \text{ V}$		1.2	_	±20.0	μΑ

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## AC Characteristics (Ta = -40 to $85^{\circ}$ C, input: $t_r = t_f = 2.0$ ns) (Note)

Characteristics	Symbol	Test 0	Condition	V <sub>CC</sub> (V)	Min	Max	Unit
			C. 45 = D. 240	1.2	40	_	
			$C_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega$	1.5 ± 0.1	80		
Maximum clock frequency	f <sub>max</sub>	Figure 1, Figure 2		1.8 ± 0.15	100	_	MHz
			$C_L = 30 \text{ pF}, R_L = 500 \Omega$	2.5 ± 0.2	200	_	
				3.3 ± 0.3	250	_	
				(/1.2)	3.0	46.0	
Propagation delay time $(\text{CK-Q}, \overline{\overline{Q}}\ )$			$C_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega$	1.5 ± 0.1	2.0	18.4	
	t <sub>pLH</sub>	Figure 1, Figure 2		1.8 ± 0.15	1.5	9.2	ns
	tpHL		$C_L = 30 \text{ pF}, R_L = 500 \Omega$	2.5 ± 0.2	0.8	4.6	
			4( >>	3.3 ± 0.3	0.6	3.5	
				1.2	3.0	46.0	
			$C_L = 15 pF, R_L = 2 k\Omega$	1.5 ± 0.1	2.0	18.4	
Propagation delay time	t <sub>pLH</sub>	Figure 1, Figure 4		1.8 ± 0.15	45)	9.2	ns
(CLR, PR-Q, Q)	t <sub>pHL</sub>	<	$C_L = 30 \text{ pF}, R_L = 500 \Omega$	2.5 ± 0.2	0.8	4.6	
				3.3 ± 0.3	0.6	3.5	
Minimum pulse width			6, 45 pt 0, 210	1.2	24	_	
	4 (11)		$G_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega$	1.5 ± 0.1	8.0	_	ns
	t <sub>W</sub> (H)	Figure 1, Figure 2		1.8 ± 0.15	4.0	_	
(CK)	t <sub>W</sub> (L)		$C_L = 30 \text{ pF}, R_L = 500 \Omega$	2.5 ± 0.2	1.5	_	
				$3.3 \pm 0.3$	1.5		
		Figure 1, Figure 4	$C_L = 15 pF, R_L = 2 k\Omega$	1.2	24		
Minimum pulse width	tw(L)		OL - 19 pi , NL - 2 K2	1.5 ± 0.1	8.0		
(CLR, PR)				$1.8 \pm 0.15$	4.0		ns
(OER,TR)			$C_L = 30 \text{ pF}, R_L = 500 \Omega$	$2.5\pm0.2$	1.5		
	$) \perp -$		(3)	$3.3 \pm 0.3$	1.5		
	$\langle$		$C_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega$	1.2	20	_	
			OL = 10 pr , NL = 2 ks2	1.5 ± 0.1	7.5	_	
Minimum set-up time	ts	Figure 1, Figure 2		1.8 ± 0.15	3.0	_	ns
4		$\wedge$	$C_L = 30 \text{ pF}, R_L = 500 \Omega$	2.5 ± 0.2	1.5	_	
		4		$3.3 \pm 0.3$	1.5	_	
	~ (		$C_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega$	1.2	8.0	_	
				1.5 ± 0.1	3.0	_	
Minimum hold time	th	Figure 1, Figure 2		1.8 ± 0.15	1.0	_	ns
	, //	$\supset$	$C_L = 30 \text{ pF}, R_L = 500 \Omega$	$2.5\pm0.2$	1.0	_	
				$3.3 \pm 0.3$	1.0	_	
			$C_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega$	1.2	24	_	ns
				1.5 ± 0.1	8.0	_	
Minimum removal time	moval time trem F	Figure 1, Figure 3	$C_L = 30 \text{ pF}, R_L = 500 \Omega$	1.8 ± 0.15	3.0	_	
				$2.5\pm0.2$	2.0	_	
				$3.3 \pm 0.3$	1.5	_	

Note: For  $C_L = 50$  pF, add approximately 300 ps to the AC maximum specification.

### Dynamic Switching Characteristics (Ta = 25°C, input: $t_r = t_f = 2.0$ ns, $C_L = 30$ pF)

Characteristics	Symbol	ol Test Condition			Тур.	Unit
Characteristics	Cymbol	1631 00	Silation	V <sub>CC</sub> (V)	۱ ۷۲۰	Offic
Quiet output maximum dynamic V <sub>OL</sub>		V <sub>IH</sub> = 1.8 V, V <sub>IL</sub> = 0 V	(Note)	1.8	0.25	
	V <sub>OLP</sub>	V <sub>IH</sub> = 2.5 V, V <sub>IL</sub> = 0 V	(Note)	2.5	0.6	V
		$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$	(Note)	3.3	8.0	
	V <sub>OLV</sub>	V <sub>IH</sub> = 1.8 V, V <sub>IL</sub> = 0 V	(Note)	1,8	-0.25	
Quiet output minimum dynamic V <sub>OL</sub>		V <sub>IH</sub> = 2.5 V, V <sub>IL</sub> = 0 V	(Note)	2.5	-0.6	V
		V <sub>IH</sub> = 3.3 V, V <sub>IL</sub> = 0 V	(Note)	3.3	-0.8	
		V <sub>IH</sub> = 1.8 V, V <sub>IL</sub> = 0 V	(Nøte)	1.8	1.5	
Quiet output minimum dynamic V <sub>OH</sub>		V <sub>IH</sub> = 2.5 V, V <sub>IL</sub> = 0 V	(Note)	2.5	1.9	V
		V <sub>IH</sub> = 3.3 V, V <sub>IL</sub> = 0 V	(Note)	3.3	2.2	

Note: Parameter guaranteed by design.

### **Capacitive Characteristics (Ta = 25°C)**

Characteristics	Symbol	Test Condition	(C	V <sub>CC</sub> (V)	Тур.	Unit
Input capacitance	C <sub>IN</sub>			1.8, 2.5, 3.3	6	pF
Power dissipation capacitance	C <sub>PD</sub>	f <sub>IN</sub> = 10 MHz	(Note)	1.8, 2.5, 3.3	20	pF

Note: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

조

Measure

Average operating current can be obtained by the equation:

Output o

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/2 (per F/F)$ 

### **AC Test Circuit**

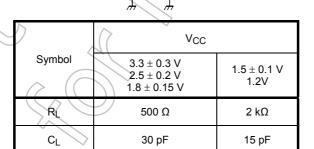
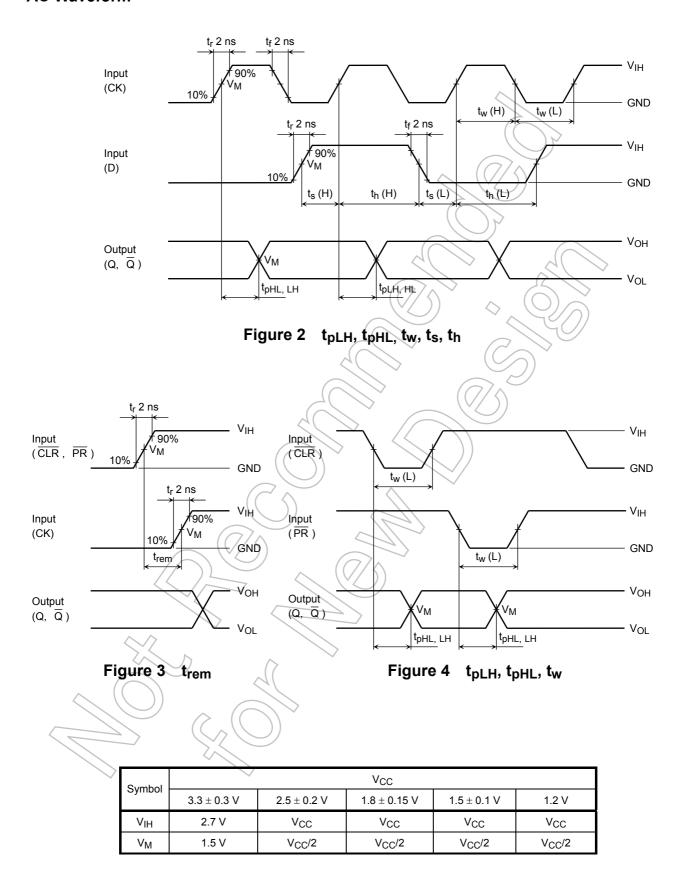


Figure 1

### **AC Waveform**

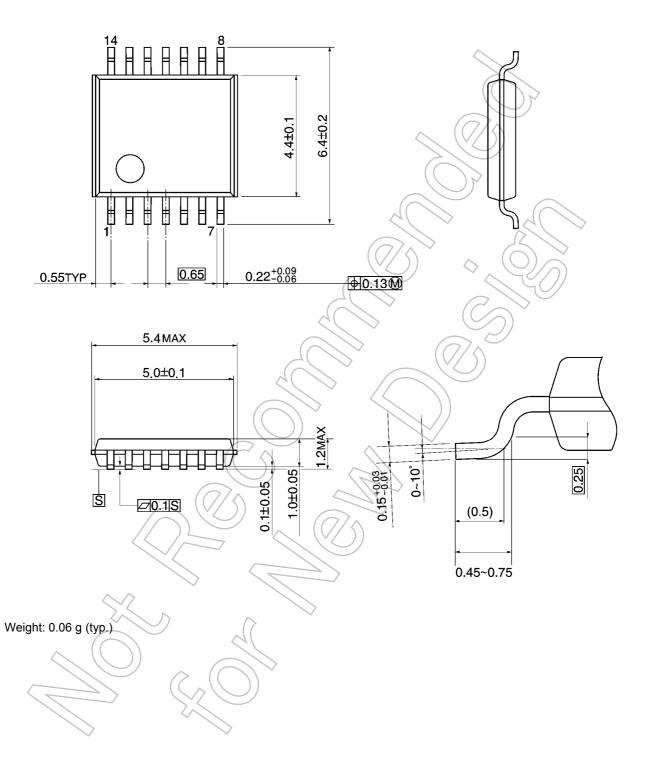


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## **Package Dimensions**

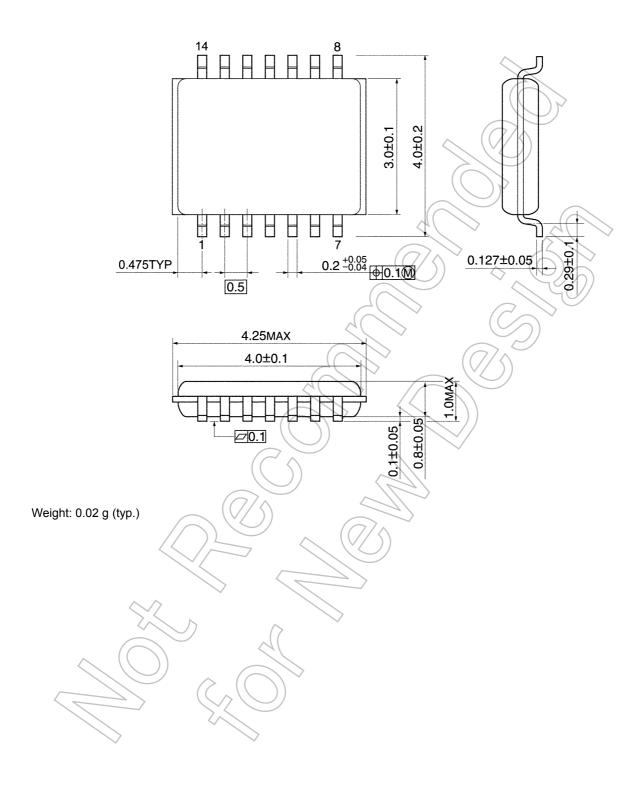
TSSOP14-P-0044-0.65A Unit: mm



## **Package Dimensions**

**TOSHIBA** 

VSSOP14-P-0030-0.50 Unit: mm



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